## MAZC062D

## Silicon planar type

For surge absorption circuit

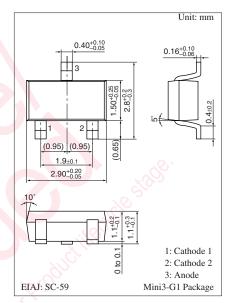
#### ■ Features

- Low joint capacity zener diode
- Two elements anode-common type

### ■ Absolute Maximum Ratings $T_a = 25$ °C

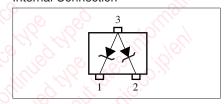
Parameter	Symbol	Rating	Unit
Repetitive peak forward current	$I_{FRM}$	200	mA
Power dissipation*	P <sub>D</sub>	200	mW
Junction temperature	Tj	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

Note) \*: P<sub>tot</sub> = 200 mW achieved with a printed circuit board.



Marking Symbol: 6.2C

#### Internal Connection



## ■ Electrical Characteristics T<sub>a</sub> = 25°C ± 3°C

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Forward voltage	$V_{\rm F}$	$I_F = 10 \text{ mA}$		0.9	1.0	V
Zener voltage*	$V_{Z}$	$I_Z = 5 \text{ mA}$	5.9		6.5	V
Zener rise operating resistance	R <sub>ZK</sub>	$I_Z = 0.5 \text{ mA}$			100	Ω
Zener operating resistance	$R_{\rm Z}$	$I_Z = 5 \text{ mA}$		30	Ω	
Reverse current	$I_R$	$V_R = 5.5 \text{ V}$			3	μΑ
Terminal capacitance	C <sub>t</sub>	$V_R = 0 V, f = 1 MHz$		8		pF

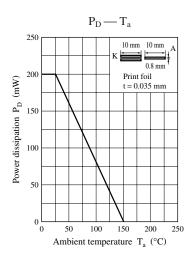
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.

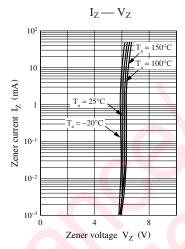
- 2. Absolute frequency of input and output is 5 MHz
- 3. Electrostatic breakdown voltage: ±15 kV

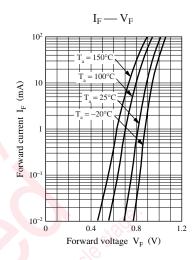
Test method: IEC-801 (C = 150 pF, R = 330  $\Omega$ , Contact discharge: 10 times)

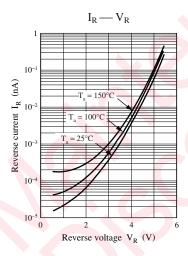
Test unit: ESS-200AX

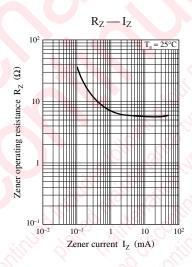
4. \*: The  $V_Z$  value is for the temperature of 25°C. In other cases, carry out the temperature compensation. Guaranteed at 20 ms after power application.

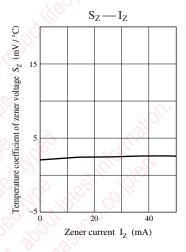


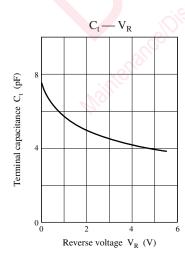












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